

TENTATIVE

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

**T 6 K 0 1****COLUMN DRIVER LSI FOR A DOT MATRIX LCD**

The TOSHIBA T6K01 is a column (segment) driver for a small-or medium-scale dot matrix LCD. The T6K01 offers low power consumption, due to the CMOS Si-Gate process. It is designed to interface directly with a microprocessor unit (MPU). A program running on the MPU can drive the T6K01 asynchronously. The T6K01 stores data transferred from the MPU in its built-in RAM. The data stored in the built-in display RAM corresponds to the image on the LCD screen; the data is converted into the LCD drive signal. A configuration of two T6K01s and one T6C03 can be used to drive a 480 x 160-dot LCD.

Unit: mm		
T6K01	LEAD PITCH	
	IN	OUT
(UAM, 4NS)	0.8	0.14

Please contact Toshiba or an authorized Toshiba dealer for information on package dimensions.

TCP (Tape Carrier Package)

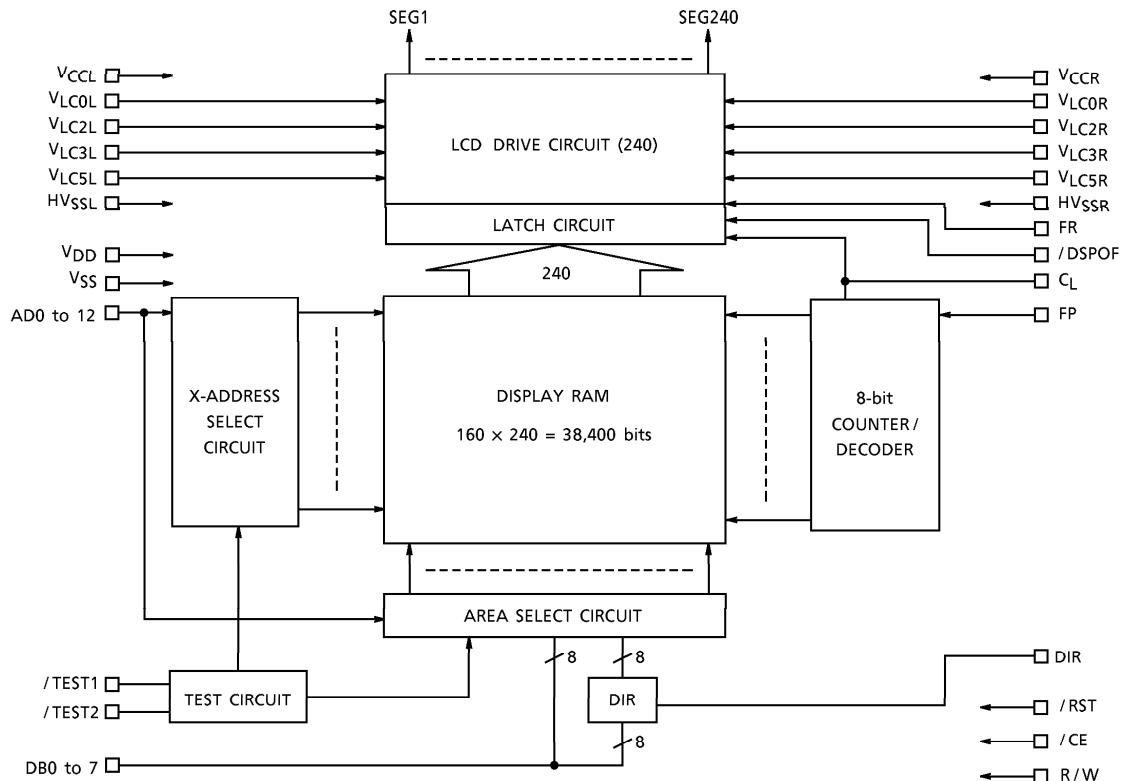
**FEATURES**

- Dot matrix graphic LCD column driver with display RAM
- Display RAM capacity: 160 lines x 240 outputs = 38400 bits
- LCD drive output: 240
- Interface: 8-bit MPU
- Relation between RAM data and display  
RAM bit data = 1 → display ON  
RAM bit data = 0 → display OFF
- Duty: Can be controlled by a T6C03 (row driver).
- Display OFF function
- Low power consumption
- Logic power supply: 2.7 to 3.3 V
- LCD power supply: 8.0 to 26.0 V
- CMOS Process
- Package: TCP (Tape Carrier Package)

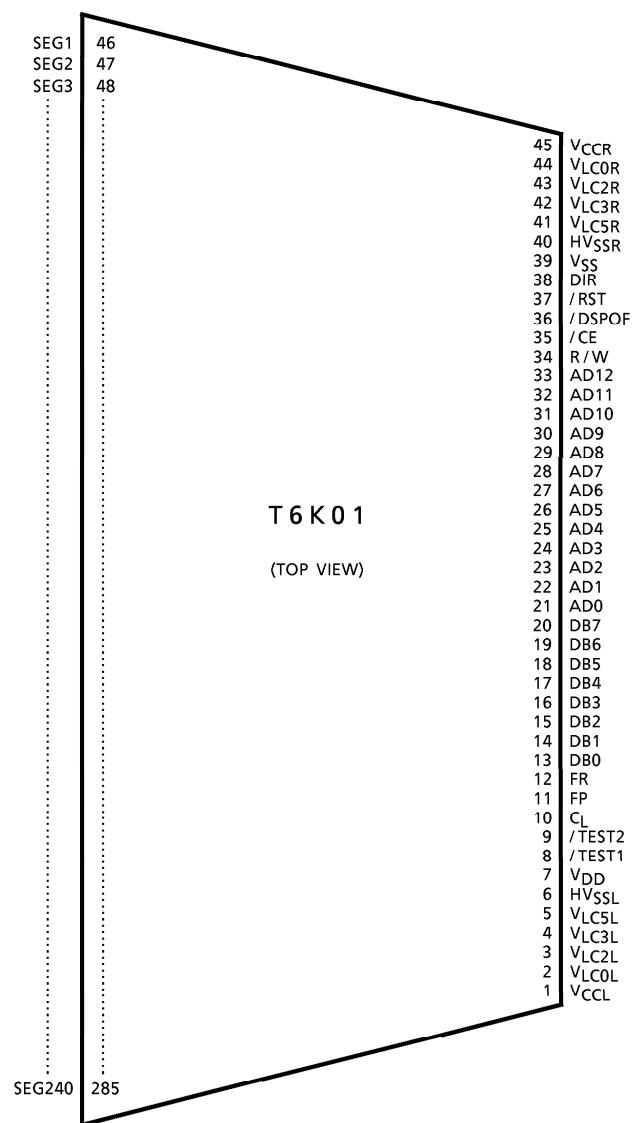
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## BLOCK DIAGRAM



## PIN ASSIGNMENT



(\*) : The above diagram shows the pin configuration of the LSI chip; it does not show the configuration of the tape carrier package.

## PIN FUNCTIONS

PIN NAME	PIN No.	I/O	FUNCTIONS
SEG1 to SEG240	46 to 285	Output	Column driver outputs
C <sub>L</sub>	10	Input	Shift clock pulse
FP	11	Input	Display synchronous signal
FR	12	Input	Frame signal
DB0 to DB7	13 to 20	I/O	Data bus
AD0 to AD12	21 to 33	Input	Address bus
R/W	34	Input	Read / write select R/W = H → Read selected R/W = L → Write selected
/CE	35	Input	Chip enable Data write : Data write enabled on rising edge of /CE Data read : Data read out while /CE is at L level
/DSPOF	36	Input	Display off. Usually connected to V <sub>DD</sub> . /DSPOF = H : Display-on mode. (SEG1 to SEG240) are operational. /DSPOF = L : Display-off mode. (SEG1 to SEG240) are at the V <sub>SS</sub> level.
/RST	37	Input	Reset signal: /RST = L → Reset state
DIR	38	Input	Data direction select
/TEST1, 2	8, 9	Input	Test pin. Usually connected to V <sub>DD</sub>
V <sub>DD</sub> , V <sub>SS</sub>	7, 39	—	Power supply
V <sub>CCL</sub> , V <sub>CCR</sub> V <sub>LC0L</sub> , V <sub>LC0R</sub> V <sub>LC2L</sub> , V <sub>LC2R</sub> V <sub>LC3L</sub> , V <sub>LC3R</sub> V <sub>LC5L</sub> , V <sub>LC5R</sub> HV <sub>SSL</sub> , HV <sub>SSR</sub>	1, 45 2, 44 3, 43 4, 42 5, 41 6, 40	—	Power supply for LCD drive

**FUNCTION OF EACH BLOCK****• RAM cell**

The RAM capacity is 160 lines  $\times$  240 outputs for a total of 38400 bits.

**• DIR**

This circuit changes the data flow direction and page selection sequence.

**• Address decoder**

This decoder selects one RAM address for read / write operation.

**• 8-bit counter + decoder**

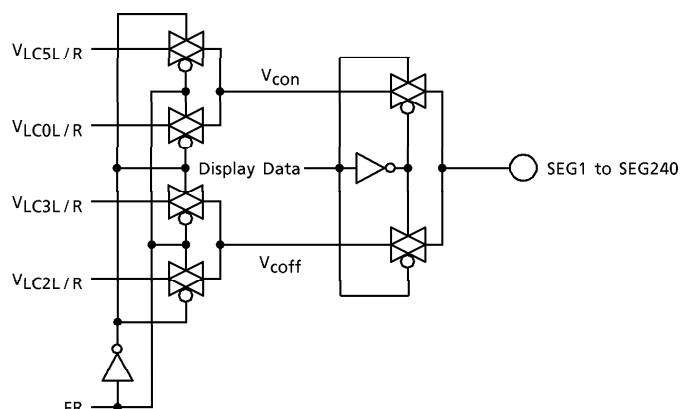
The decoder selects one RAM cell from the 160 address lines for display operation.

**• Latch**

The data is latched from the display RAM on the falling edge of  $C_L$ .

**• Column driver circuit and LCD voltage generation circuit**

The T6K01 has 240 column drivers and four different LCD drive output voltage levels. The display data from the latch circuit and the M signal determine which of the four LCD drive voltages is selected. This circuit is shown in the following diagram.

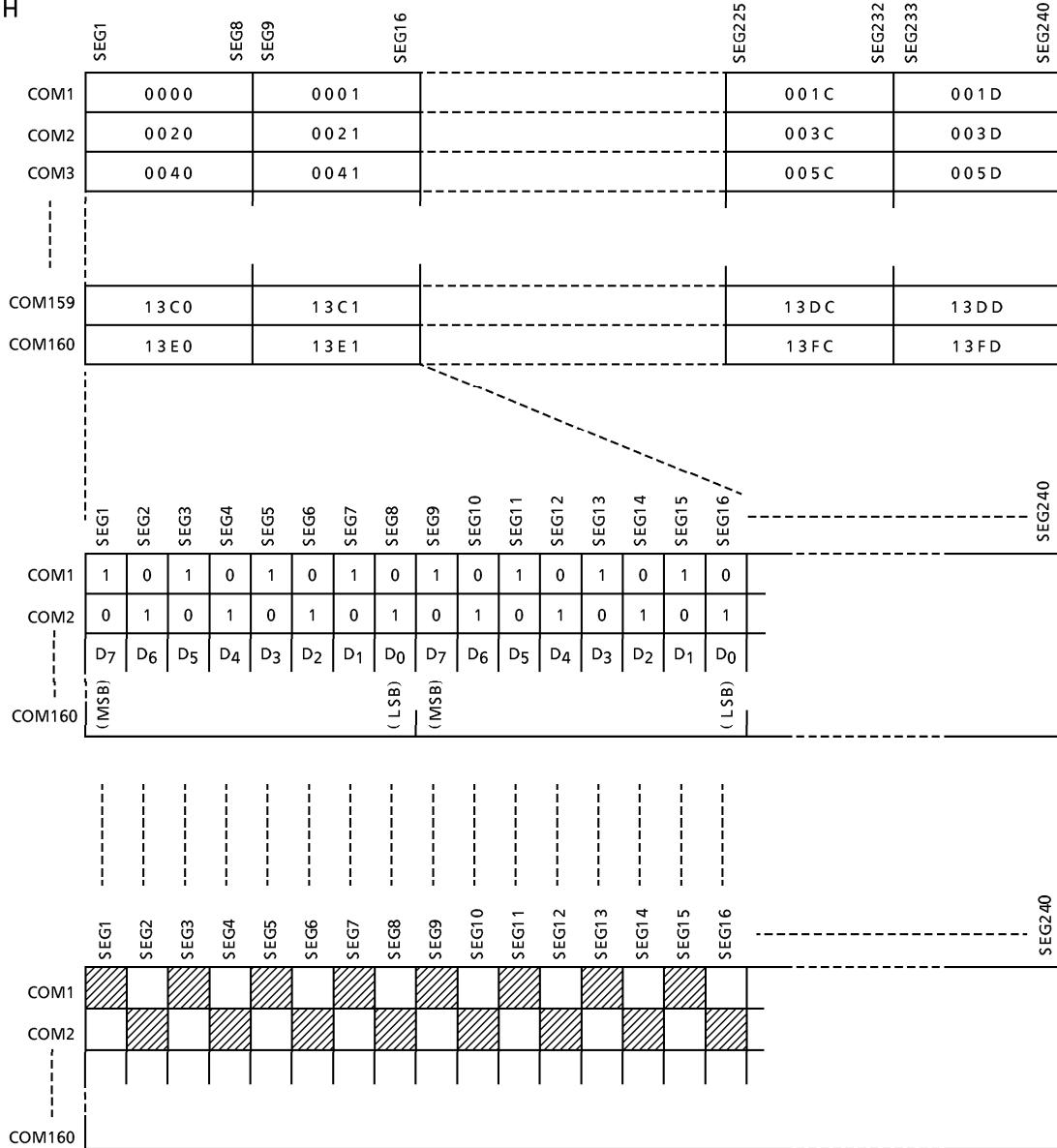
**RELATION BETWEEN FR, DATA INPUT AND OUTPUT LEVEL**

/ DSPOF	FR	INPUT DATA (RAM DATA)	OUTPUT LEVEL
L	*	*	$V_{SS} / V_{LC5}$
H	L	L	$V_{LC3}$
H	L	H	$V_{SS} / V_{LC5}$
H	H	L	$V_{LC2}$
H	H	H	$V_{LC0}$

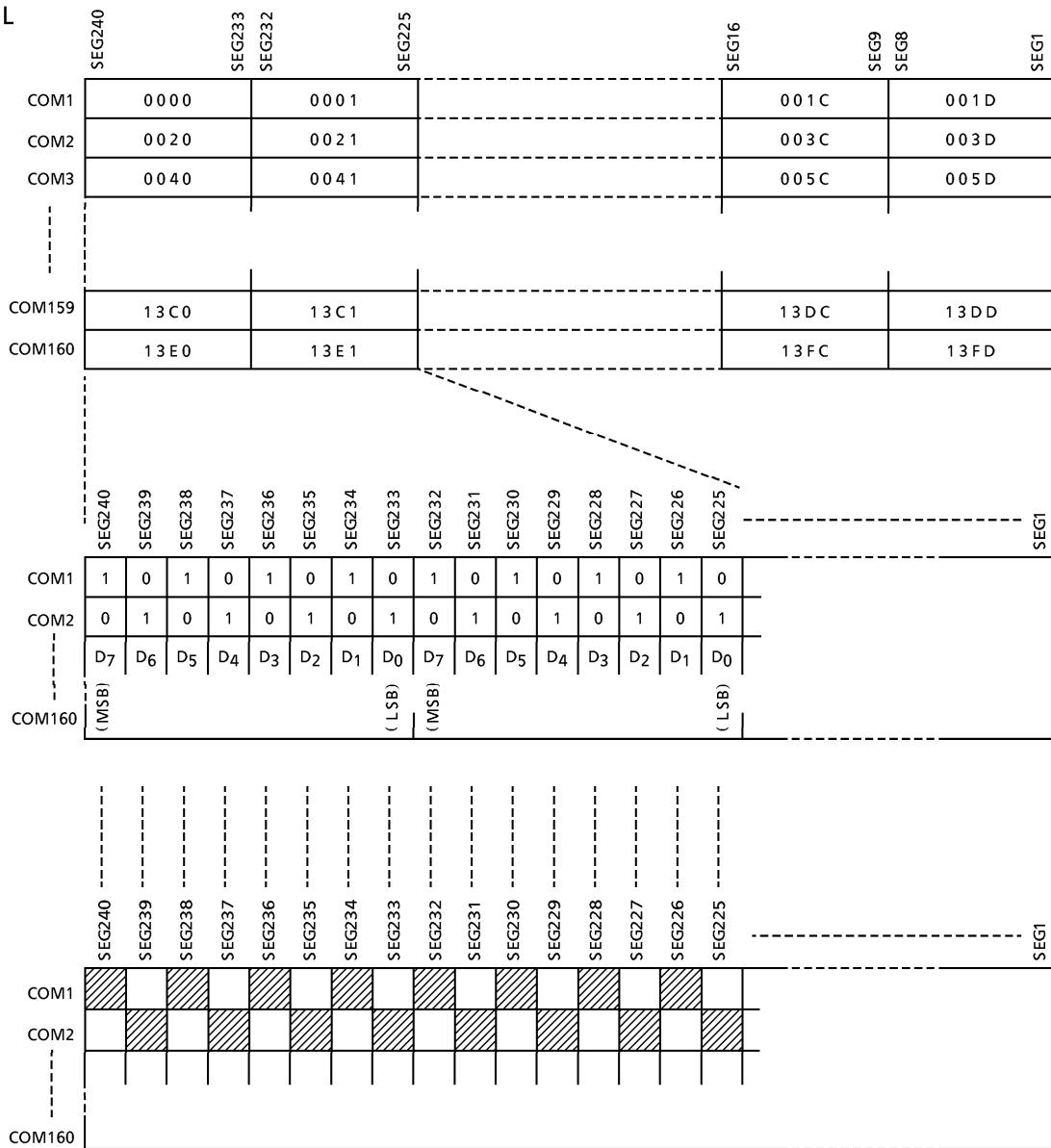
\* : INVALID

- The relation between DIR and the memory map

### (1) DIR = H



(2) DIR = L



**ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)**

ITEM	SYMBOL	RATING	UNIT
Supply Voltage (1)	V <sub>DD</sub> (Note 2)	-0.3 to 6.5	V
Supply Voltage (2)	(Note 1, 2)	-0.3 to 28.0	V
Input Voltage	V <sub>IN</sub> (Note 2, 3)	-0.3 to V <sub>DD</sub> + 0.3	V
Operating Temperature	T <sub>opr</sub>	-20 to 75	°C
Storage Temperature	T <sub>stg</sub>	-55 to 125	°C

(Note 1) : V<sub>CCL</sub>, V<sub>CCR</sub>, V<sub>LC0L</sub>, V<sub>LC0R</sub>, V<sub>LC2L</sub>, V<sub>LC2R</sub>, V<sub>LC3L</sub>, V<sub>LC3R</sub>, V<sub>LC5L</sub> and V<sub>LC5R</sub>

(Note 2) : Referenced to V<sub>SS</sub>, HV<sub>SSL</sub> and HV<sub>SSR</sub>

(Note 3) : Applies to all data bus and I/O pins.

(Note 4) : Ensure that the following condition is always maintained.

$$V_{CCL}/R \geq V_{LC0L}/R \geq V_{LC2L}/R \geq V_{LC3L}/R \geq V_{LC5L}/R \geq HV_{SSL}/R$$

**ELECTRICAL CHARACTERISTICS****DC CHARACTERISTICS****TEST CONDITIONS**(Unless otherwise noted,  $V_{SS} = 0\text{ V}$ ,  $V_{DD} = 3.0\text{ V} \pm 10\%$ ,  $V_{CCL/R} = 23.0\text{ V} \pm 10\%$ ,  $T_a = -20$  to  $75^\circ\text{C}$ )

ITEM		SYMBOL	TEST CIR-CUIT	TEST CONDITOIONS	MIN	TYP.	MAX	UNIT	PIN NAME
Operating Supply (1)	$V_{DD}$	—	—	—	2.7	—	3.3	V	$V_{DD}$
Operating Supply (2)	$V_{CC}$	—	—	—	8.0	—	26.0	V	$V_{CCL}, V_{CCR}$
Input Voltage	H Level	$V_{IH}$	—	—	0.7 $V_{DD}$	—	$V_{DD}$	V	DB0 to DB7 AD0 to AD7, /RST /DSPOF, /CE
	L Level	$V_{IL}$	—	—	0	—	0.3 $V_{DD}$	V	R/W, D/I, $C_L$ , FP FR, DIR, /TEST
Output Voltage	H Level	$V_{OH}$	—	$I_{OH} = -400\text{ }\mu\text{A}$	$V_{DD} - 0.4$	—	$V_{DD}$	V	DB0 to DB7
	L Level	$V_{OL}$	—	$I_{OL} = 400\text{ }\mu\text{A}$	$V_{SS}$	—	0.4	V	
Column Driver Output Resistance	$R_{col}$	—	Load current $= \pm 100\text{ }\mu\text{A}$ (Note 4)	—	—	—	3.0	$\text{k}\Omega$	SEG1 to SEG160
Input Leakage	$I_{IL}$	—	$V_{IN} = V_{DD}$ to $V_{SS}$	—1	—	1	$\mu\text{A}$	DB0 to DB7 AD0 to AD7, /RST /DSPOF, /CE R/W, D/I, $C_L$ , FP FR, DIR, /TEST	
Operating Freq.	$f_{CL}$	—	—	10	—	50	$\text{kHz}$	$C_L$	
Current Consumption (1)	$I_{SS1}$	—	(Note 1)	—	410	520	$\mu\text{A}$	$V_{SS}, HV_{SSL}, HV_{SSR}, VLC5L, VLC5R$	
Current Consumption (2)	$I_{SS2}$	—	(Note 2)	—	45	65	$\mu\text{A}$	$V_{SS}, HV_{SSL}, HV_{SSR}, VLC5L, VLC5R$	
Current Consumption (3)	$I_{SS3}$	—	(Note 3)	-1	—	1	$\mu\text{A}$	$V_{SS}, HV_{SSL}, HV_{SSR}, VLC5L, VLC5R$	

(Note 1) : Current consumption while internal data receiver is operating

 $V_{DD} = 3.0\text{ V} \pm 10\%$ ,  $V_{CCL/R} = 23.0\text{ V}$ ,  $T_a = 25^\circ\text{C}$ , 1/13 bias, 1/160 duty, no load,  
 $f_{FP} = 70\text{ Hz}$ ,  $f/CE = 5\text{ MHz}$ 

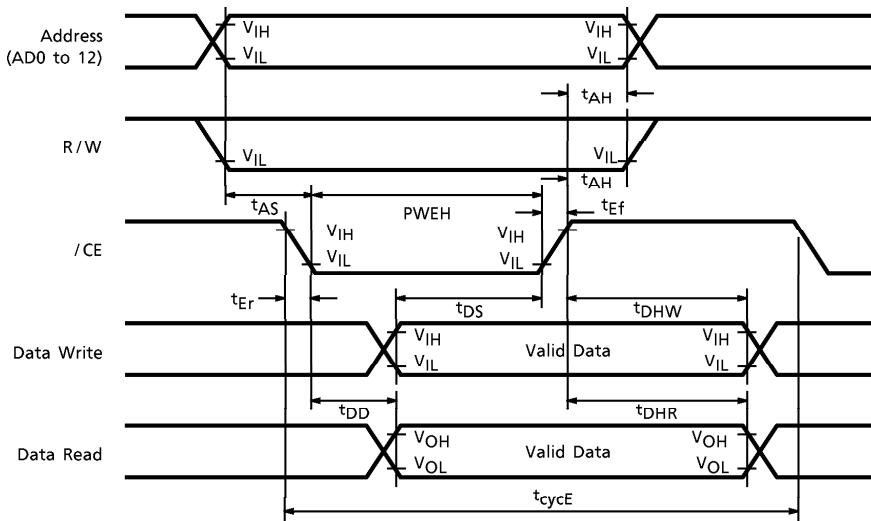
(Note 2) : Current consumption while internal data receiver is sleeping

 $V_{DD} = 3.0\text{ V} \pm 10\%$ ,  $V_{CCL/R} = 23.0\text{ V}$ ,  $T_a = 25^\circ\text{C}$ , 1/13 bias, 1/160 duty, no load,  
 $f_{FP} = 70\text{ Hz}$ ,  $f/CE = 0\text{ Hz}$ 

(Note 3) : Standby current consumption

 $V_{DD} = 3.0\text{ V} \pm 10\%$ ,  $V_{CCL/R} = 23.0\text{ V}$ ,  $T_a = 25^\circ\text{C}$ , no load,  $f_{FP} = 0\text{ Hz}$ ,  $f/CE = 0\text{ Hz}$ 
(Note 4) :  $V_{CCL/R} = V_{LC0L/R} = 23.0\text{ V}$ ,  $V_{LC2L/R} = V_{CC} \times 11/13$ ,  $V_{LC3L/R} = V_{CC} \times 2/13$ ,  
 $HV_{SSL/R} = VLC5L/R = 0\text{ V}$

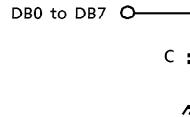
## AC CHARACTERISTICS (1)



TEST CONDITIONS ( $V_{SS} = 0 \text{ V}$ ,  $V_{DD} = 3.0 \text{ V} \pm 10\%$ ,  $T_a = -20 \text{ to } 75^\circ\text{C}$ )

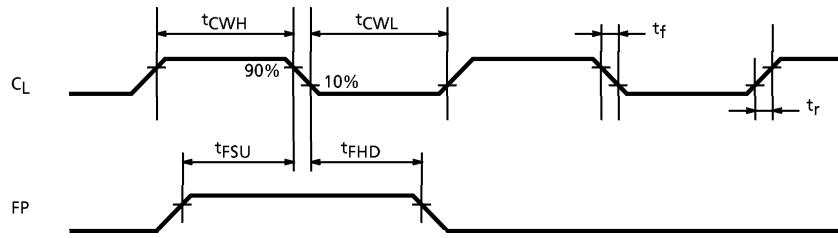
ITEM	SYMBOL	MIN	MAX	UNIT
Enable Cycle Time	$t_{cycE}$	250	—	ns
Enable Pulse Width	$PWEH$	160	—	ns
Enable Rise / Fall Time	$t_{Er}, t_{Ef}$	—	20	ns
Address Set-up Time	$t_{AS}$	0	—	ns
Address Hold Time	$t_{AH}$	10	—	ns
Data Set-up Time	$t_{DS}$	100	—	ns
Data Hold Time	$t_{DHW}$	20	—	ns
Data Delay Time	$t_{DD}$ (Note)	—	180	ns
Data Hold Time	$t_{DHR}$ (Note)	20	—	ns

## LOAD CIRCUIT



$C = 40 \text{ PF}$   
(including wiring capacitance)

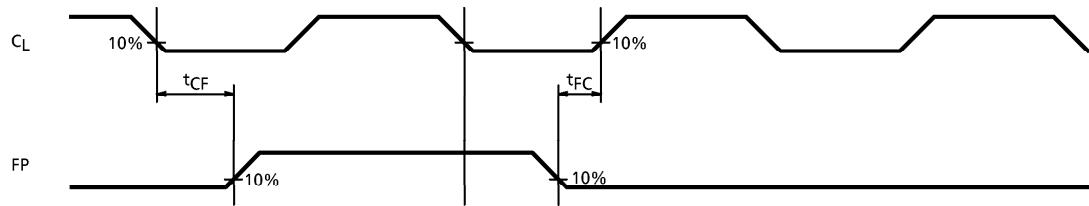
**AC CHARACTERISTICS (2)**  
Display data



TEST CONDITIONS ( $V_{SS} = 0 \text{ V}$ ,  $V_{DD} = 3.0 \text{ V} \pm 10\%$ ,  $T_a = -20 \text{ to } 75^\circ\text{C}$ )

ITEM	SYMBOL	PIN NAME	MIN	MAX	UNIT
$C_L$ Pulse Width H	$t_{CWH}$	$C_L$	500	—	ns
$C_L$ Pulse Width L	$t_{CWL}$	$C_L$	500	—	ns
$C_L$ Rise / Fall Time	$t_r, t_f$	$C_L$	—	50	ns
FP Set-up Time	$t_{FSU}$	FP	100	—	ns
FP Hold Time	$t_{FHD}$	FP	100	—	ns

**AC CHARACTERISTICS (3)**



ITEM	SYMBOL	CONDITION	MIN	MAX	UNIT
$C_L$ -to-FP-margin time	$t_{CF}$		20	—	ns
FP-to- $C_L$ -margin time	$t_{FC}$		0	—	ns

**APPLICATION CIRCUIT**  
T6K01 + T6C03

